MgO Effect on The Dielectric Properties of BaTiO$_3$

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Abstract—The dielectric properties of barium titanate as functions of the MgO addition in various rates are investigated in this paper. The ceramics were prepared by conventional methods. X-ray diffraction, scanning electron microscopy and energy dispersive spectrometry, were applied to determine the structure and microstructure of the studied material. Phases MgO, TiO and TiO$_2$ have been detected. Decrease of the grain size with increasing MgO content was observed. Measurements of $\varepsilon_r$, $\text{tg}\delta$ and resistance have been performed at temperatures ranging from 30°C to 400°C. The electric permittivity ($\varepsilon_r$) showed a considerable decrease with increasing MgO concentration. Additionally, for low MgO concentration (10±5mol.% MgO) a shift of the dielectric loss peak ($\text{tg}\delta_m$) towards low temperatures was observed. When the MgO content was ≥15mol.% MgO the $\text{tg}\delta_m$ moved into higher temperatures. The obtained results indicate that the substitution of Mg$^{2+}$ ions in B-site ions (Ti$^{4+}$) had a significant influence on the values of $\varepsilon_r$, $\text{tg}\delta$ and the resistance increase of the ceramics.

Keywords-BaTiO$_3$; MgO-doped BaTiO$_3$; thermostats PTC; dielectric properties; electric permittivity

I. INTRODUCTION

Barium titanate (BaTiO$_3$) is considered one of the most promising systems for applications in electro-optic devices, memory devices, temperature sensors, time delay circuits, current limiters, current stabilizers and capacitors [1]. BaTiO$_3$ is used as doping in other electrical engineering applications such as varistors [2] and in polymer composites like cable insulation sheaths [3, 4]. The dielectric and ferroelectric properties of BaTiO$_3$ can be efficiently controlled by dopant addition. BaTiO$_3$ is used in electric devices manufactured to work at temperatures less than its Curie temperature ($T_C$=120°C). In devices functioning at a temperature other than 120°C, it is mixed with other materials such as Mg, PbTiO$_3$ (PT), Zr oxide, and other oxides, in order to shift $T_C$ above or under 120°C [5-11]. Pure BaTiO$_3$ exhibits very high electric permittivity, since it has positive -temperature-coefficient resistivity (PTCR) above the Curie temperature [12, 13]. This phenomenon was considered as a consequence of the double Schottky barrier, formed at the grain boundaries and of the strong temperature dependence [14]. The PTCR phenomenon of doped BaTiO$_3$ has been explained in [13, 15]. It has been concluded that the PTCR effect is caused by defect distribution in the samples. The effects of sintering conditions have been investigated in [11, 13, 16-19].

Because BaTiO$_3$ as additive in a varistor based ZnO, reduced the grain growth of ZnO as a function of the content of BaTiO$_3$. It is found that an excess of 9.6wt% BaTiO$_3$ leads to the BaTiO$_3$ phase segregation on the surface of the sample [2]. MgO-doped BaTiO$_3$ has been less studied. MgO is very often added at small amounts, less than 3mol.%. This MgO ratio is generally used in multi-component BaTiO$_3$-based ceramics, as high temperature capacitor in order to improve their temperature stability. MgO as an alloyant in BaTiO$_3$ plays a decisive role in achieving ultra-broad temperature stability [20-23]. The effect of the alloyant dopant on the bulk electrical conductivity is strongly dependent on its substitution site in the BaTiO$_3$ perovskite structure. Site replacement in the crystal lattice mainly depends on the dopant’s ionic radius [8, 10, 13]. For small ions, with ionic radius $r<0.09$nm, dopants preferentially occupy the Ti site. For intermediate ions, with $0.09$nm<$r<0.099$nm, dopants can substitute either Ti or Ba depending on dopant concentration, sintering conditions and Ba/Ti molar ratio. For larger ions, with $r>0.099$nm, dopants preferentially occupy the Ba sites. In [21-22], the solid solution between MgO (content <1.5%) and BaTiO$_3$ presents a XRD pattern, characteristic of a single phase structure (BTO). This implies that Mg$^{2+}$ ions have entered the unit cell maintaining the perovskite structure of solid solution. MgO phase in addition to the BTO phase, is detected for Mg contents, greater than 1.5% [21].

Electro-conductive composite ceramics are composed of an independent phase, of conglomerates and a continuous phase connecting mutually the independent phase of conglomerates. They are composed of an independent phase of conglomerates (50%-98% by weight) and of a continuous phase (2%-50% by weight) [24]. These ceramics can exhibit stable electro conductivity-temperature characteristics. They can be excellent in thermal shock resistance, in mechanical strength, and in chemical resistance. Concerning MgO-doped BaTiO$_3$ composite, only a few studies have been made [25]. In this paper, 5mol.%, 10mol.%, 15mol.%, 20mol.%, 30mol.%, and 50mol.% MgO-doped BaTiO$_3$ have been studied. The study aims to modify the BT-based materials characteristics such as $T_C$, electric permittivity and broaden the maxima peak. Sintering effect, microstructural evolution and incorporation degree of Mg into lattices (BaTiO$_3$) have been discussed as functions of the MgO content. Electric permittivity and resistance have been measured in temperatures ranging from 20°C to 400°C.
II. EXPERIMENTAL PROCEDURE

High-purity commercial powder BaTiO$_3$ (code 01-081-2200), obtained from ALFA AESAR, was used as starting material with 70nm grain size. Using a conventional ceramic procedure, BaTiO$_3$-based varistor samples, doped with various contents of MgO (0, 5, 10, 15, 20, 30, 50 mol.%) were prepared. These samples are termed as BTM0, BTM5, BTM10, BTM15, BTM20, BTM30 and BTM50 respectively. Reagent grade oxides were mixed and homogenized in absolute ethanol media for 2 hours by planetary high-energy ball milling in a polyethylene bowl with zirconia balls. The slurry has been dried and sieved through a 200 mesh screen to produce granules without binder. The obtained powder was calcined at 1150°C for two hours in air at heating and cooling rates of 5°C/min. After drying and granulating with polyvinyl alcohol (PVA 4wt%) granules were uniaxially pressed into pellets under 20MPa and then CIPed at 200MPa. The pellets were placed in an alumina crucible and sintered at 1250°C for 2h in air at heating and cooling rates of 5°C/min, and silvered on both sides for electrical measurements. Silver electrodes were deposited by screen printing on each face. The sintered samples were all lapped and polished to be 1.0mm thick. The final samples had about 8mm i diameter and 1.0mm thickness. The samples were characterized by X-ray diffraction (XRD) using an automated diffractometer, Phillips PW-1710 type, coupled to a copper anode X-Ray tube. The microstructure of the samples was characterized by scanning electron microscopy (SEM type Hitachi-S2150) equipped with energy dispersive X-ray (EDX) spectrometer for elemental analysis. Dielectric measurements were carried out with the use of an impedance analyzer RLC (Wayne Kerr 6420). The measurements have been performed from room temperature up to 400°C, at a heating rate of 3°C/min. $\sigma$, $\tan\delta$, and resistance were measured. Under an alternate electric field, the electric permittivity of the material can be expressed by a complex permittivity such $\varepsilon = \varepsilon'(\omega) - j\varepsilon''(\omega)$. The dielectric loss tangent is defined as $\tan\delta = \varepsilon''/\varepsilon'$. In the following, we use the simplified notation $\varepsilon$, and we will speak simply of permittivity to denote the real part of relative permittivity $\varepsilon'(\omega)$.

III. RESULTS AND DISCUSSION

Commercial powder (BaTiO$_3$) was used. It is composed of a very small agglomeration, whereas the grains were very fine, of the order of 70nm. Figure 1 shows a SEM image of the commercial BaTiO$_3$ powder. We can see grain sizes smaller than one micrometer. In order to analyze the effect of MgO content on the microstructure and grain sizes, the samples have been characterized by SEM and XRD. Figure 2 shows the SEM images and EDX spectra of samples BTM0, BTM5 and BTM10 sintered at 1250°C. We can see in Figure 2(a) that the grain sizes of BaTiO$_3$, are larger in comparison with the ones of the same sample before sintering (Figure 1). They are larger than 1µm, while some are even larger than 10µm. The bimodal microstructure of fine and large matrix grains can be attributed to the temperature effect, as in the case of ZnO [2] and to presence of titanium oxide. The EDX spectrum characteristic of BTM0 (Figure 3(a)) indicates that, there are 60.30 atom% of oxygen, 20.77 atom% of Ti and 18.84 atom% of Ba.

Fig. 1. SEM image of the commercial BaTiO$_3$ powder

Fig. 2. SEM image of MgO-doped BaTiO$_3$ after sintering at 1250°C (a) BTM0, (b) BTM5, (c) BTM10

The grain size of BTM0 (pure) has increased under the temperature effect. Figures 2(b) and 3(b) show the morphology
and EDX spectrum of the sample BTM5. We can see that the grains are smaller. The surface morphology revealed some clear grain shapes. Figure 2(b) is brighter than Figure 2(a). We can see some bright domains, characteristics of MgO. The incorporation of MgO particles into the matrix is confirmed by EDX spectrum (Figure 3(b)). Au peak artifacts of sample preparation and support grid are noticed. In Figure 2(c), of the sample BTM10, the brightness domains are greater, the grain sizes are smaller and the brightness is stronger than that of Figure 2(b), since MgO content is greater than that of the samples BTM0 and BTM5.

Fig. 3. EDX spectrum of MgO-BaTiO$_3$ compared with pure BaTiO$_3$. (a) BTM0, (b) BTM5, (c) BTM10

We can see the effect of MgO on the microstructure of the sample. The doping with MgO led to a consequent decrease in the grain size. The samples sintered at 1250°C show that grain sizes are smaller, whereas, undoped BaTiO$_3$ exhibits larger grain sizes (greater than 1µm). The most large grain size was estimated to be 10µm. For the sample BTM10, the grain size was in the order of 300nm. The result is in agreement with the findings in [21]. Incorporation of MgO particles in BaTiO$_3$ led to the grain growth inhibition of the composite. Even in other system such as (Ba$_{1-x}$Ca$_x$)$_3$TiO$_3$–MgO–SiO$_2$, MgO has been detected in the grain boundary region where MgO acts as a grain growth inhibitor [8, 26]. It is thus confirmed that in a MgO–BaTiO$_3$ system the grain growth is inhibited by the secondary phase which can be due to excess of MgO, existing in the grain boundary.

EDX mapping of elemental distribution of Ba, Ti, Mg and O has shown that MgO is highly dispersed in the BaTiO$_3$ matrix. We can see that the density of Mg in the BTM10 sample is greater than that of the sample BTM5. The distribution of the chemical elements is homogenous except for Mg in BTM10 probably near the grain boundaries where the solid solutions can be located. The non-homogeneity is characterized by a strong concentration in these regions. These are the dark regions in the SEM image representing the morphology of the sample. The SEM image and mapping of elemental distribution shows that BaTiO$_3$ seems to be covered with MgO particles.

A. X-Ray Diffraction

The diffraction pattern of X-ray (XRD) of these powders was performed for 45min at angle of 2θ, in temperatures ranging from 20°C to 80°C. The XRD spectra of the samples, BTM0, BTM5 and BTM10 sintered at 1250°C, are shown in Figure 4. The pure BaTiO$_3$ spectrum has been used as a reference.

![XRD spectra](image)

Fig. 4. XRD spectra of (a) BTM10, (b) BTM5 and (c) BTM0 sintered at 1250°C

1) BTM0

A representative XRD spectrum of the sample BTM0 is shown in Figure 4(c). The XRD study confirms the formation of the cubic system. All diffraction peaks coincide to that one of reference code 01-074-1964 where lattice parameter was equal to 4.0060Å. The obtained diffraction pattern is characteristic of a single perovskite phase.
2) BTM5

The XRD spectrum of the sample BTM5 (Figure 4(b)), reveals that the microstructure consists of three phases: BaTiO$_3$ grain (primary phase) characterized by a peak appearing at an angle of 20=31.559° and corresponding to (110) reflection plane. The other phases, MgO and TiO$_2$ are characterized by peaks appearing, at angles 20=42.917° and 20=28.527° and correspond to (200) and (421) reflection planes respectively. The peak corresponding to the reflection plane is smaller (421). The parameters of these phases are given in the Table I. The increase in lattice constant of MgO-doped BaTiO$_3$ supports that Mg$^{2+}$ ions occupy Ti sites and expand the cell size, which is compatible with the acceptor doped behavior of MgO-doped BaTiO$_3$. Three phases are detected in BTM5. The result suggests that the solubility limit of MgO in BaTiO$_3$ has been exceeded whereas authors in [21] evaluate it between 1 and 1.5 at.%. They found only a second phase (MgO) from 2 at.% of excess which is located in the grain boundaries. Furthermore, TiO$_2$ phase was formed via the reaction of MgO with BaTiO$_3$. The Ti atoms seem also segregated in the grain boundaries (primary phase) characterized by a peak appearing at an angle of 2θ=31.559° and corresponding to (110) reflection plane. The detection of TiO$_2$ phase indicates that the microstructure consisted mainly of four phases: BaTiO$_3$, MgO and TiO$_2$, and TiO$_2$ has not been detected. MgO phase is the non-dissolved secondary phase (MgO) has not been detected. However, our samples contain more than 5 mol.% MgO. The solid solution between MgO and BTO occurred by dissolution of a low amount of MgO (<1.5 at.% MgO) into BaTiO$_3$ and Mg$^{2+}$ replaces Ti$^{4+}$, since the ionic radius of Mg$^{2+}$ is larger than that of Ti$^{4+}$. This result is in agreement with [8, 16, 21, 22]. As our samples contain more than 1.5 at.% MgO, other phases of MgO and TiO$_2$ have been detected. MgO phase is the non-dissolved excess which is located in the grain boundaries. Furthermore, TiO$_2$ phase was formed via the reaction of MgO with BaTiO$_3$. The Ti atoms seem also segregated in the grain boundaries under oxide form. The segregation phenomenon is explained below using the energies of oxides formation. Otherwise, in the multi-component BaTiO$_3$-based ceramics, the Ti-rich phase forms via the reaction of excess TiO$_2$ with BaTiO$_3$, but MgO addition suppresses the Ti-rich phase as reported in [20]. Our bi-component sample (BTM5) seems to be insufficient to suppress the Ti-rich phase. The XRD spectrum of the sample BTM10 (Figure 4(a)) reveals that the microstructure consists mainly of four phases: i) A primary phase (BaTiO$_3$ grains) characterized by a peak appearing at an angle 20=31.559° and corresponds to (110) reflection plane, ii) the MgO phase characterized by a peak appearing at an angle 20=42.906° and corresponds to (200) reflection plane, iii) the TiO$_2$ phase characterized by a peak appearing at an angle 20=27.91° and corresponding to (110) reflection plane, and finally iv) the TiO$_2$ phase characterized by a peak appearing at an angle 20=43.671° and corresponding to (240) reflection plane. The detection of TiO$_2$ phase indicates that 10 mol.%, as ratio of MgO, begins to reduce a part of TiO$_2$ phase into TiO$_2$ phase. The parameters of these phases are given in Table II. We can see that MgO density has increased in comparison with the density of BTM5 (Table I), while those of BaTiO$_3$ and TiO$_2$ have kept the same values. The result is in agreement with [27], and indicates that the amount of intergranular pores is decreasing with increasing MgO. Consequently, the hardness of the BaTiO$_3$-MgO composite increased with increase in the MgO content.

The models of diffusion and segregation, based on the sublimation enthalpies (bond energy) and the bond-breaking theory, are detailed in [28-30]. A preferential interaction coefficient ($\beta$) between the various atoms has been used to explain the evolution of the segregation. Concerning BaTiO$_3$, $\beta_{\text{MgO}}$, $\Delta G_{\text{TiO}_2 \rightarrow \text{G}_{\text{BaO}, \text{G}_{\text{TiO}_2 \text{BaO}}}}$ are the enthalpies of mixing of the intermetallic compound.

If $\beta$>0 there is interaction between Ba and oxygen. The segregation energy of Ba increases with the superficial concentration of O.

If $\beta$<0, the interaction between Ba and oxygen is of repulsive type. The element with the stronger tendency to segregate will push the other elements towards the bulk.

The obtained results concerning the sample BTM10 can be explained as follows.

Taking account of mixing enthalpies of components BaO (-609.4kJ/mol), MgO (-603.6kJ/mol), TiO$_2$ (-940kJ/mol), Mg$^{2+}$ (-46.685kJ/mol), Ti (468kJ/mol), the component having the lowest heat, of sublimation, segregates to grain boundaries (or to the surface) and the element that has the stronger tendency to segregate, pushes the other elements towards the bulk. The calculation method of segregation energy is developed in [28-30]. The TiO$_2$ enthalpy is the smaller ($\beta$=-331). This one segregates to grain boundaries and pushes MgO to the bulk, therefore Mg$^{2+}$ substitutes for Ti$^{4+}$, since Ti$^{4+}$ and Mg$^{2+}$ ions have respectively, 0.605 and 0.720Å radius. Mg$^{2+}$ ion is more likely to replace the Ti$^{4+}$ ions instead of substituting for Ba$^{2+}$ (1.61Å) [16]. Also, as the mixing enthalpies of components BaO and MgO are very close, the dissolution of MgO into BaTiO$_3$ was easier. Thus, when MgO content is greater than 1.5% (as carried out in [21]), the exceed is located in the grain boundaries or adsorbed at the surface [16, 23].

Concerning the fourth phase (TiO$_2$) it is known that beyond the oxygen solubility limit into titanium, different oxides can be formed such as Ti$_2$O$_3$, Ti$_2$O$_5$ and TiO$_2$. However, stability of TiO$_2$ has been obtained for an oxygen content between 34.5 at.% and 55.6 at.% [31]. The ratio of measured oxygen (60.25 at.%) is beyond this limit confirming the stability of the TiO$_2$ phase. However, the driving force for the formation of the TiO$_2$ originates from the respective energies of formation [32]. Segregation and Ti oxide formation depend on temperature, oxygen pressure and exposition time. TiO$_2$ phase has been
detected only in BTM10 which contains 60.25 at.% oxygen. The energy of TiO formation is greater than that of TiO₂, therefore, it is expected to detect, especially TiO₂ but the result indicates reduction of TiO₂ into TiO if one considers that the titanium segregates, under TiO₂ form. In this case, the chemical reaction of TiO₂ reduction can be considered. As the energy of TiO formation (-517.9 kJ/mol) is greater than that of BaO, β will be greater than 0, so it is equal to 91.5 kJ/mol. Thus, TiO cannot segregate from grains towards grain boundaries. It is formed in the grain boundaries after the reduction of TiO₂ into TiO. The chemical reaction can be explained by using Ellingham diagram which shows the stability of the oxide as a function of temperature. A given metal can reduce the oxides of all metals whose lines lie above its own on the diagram. For Mg, 2Mg + O₂ ↔ 2MgO line lies below the Ti + O₂ ↔ TiO₂ line and so Mg can reduce TiO₂ into Ti. For higher content of MgO (greater than 5 mol%), a part of TiO₂ is dissolved in the matrix, another part is reduced into TiO if the partial oxygen pressure in the matrix is lower than the equilibrium pressure value with the metal oxide at a given temperature. The remainder of TiO₂ is located in the grain boundaries. The result is in agreement with [20-22] since MgO was detected in the grain boundary regions of the system.

TiO₂ reduction into TiO, can be explained in the following way. Ti atoms, or a portion of them, can segregate in the grain boundaries under metallic form, instead of oxide form, and Mg atoms (under metallic form) diffuse into the matrix. Oxidations of Ti and Mg occur respectively in the grain boundaries and in the matrix. The formed oxides will depend of the oxygen amount in the matrix. If the oxygen amount located in the grains boundaries is low, TiO oxide can be formed, in addition to TiO₂ oxide. Finally, from the results of the microstructure, density data and XRD analysis as reported in [22] suggest that a quantity of MgO did not dissolve into the BaTiO₃ and remains present under the form of phase inclusion in the BaTiO₃ matrix and is located in the BaTiO₃ grain boundaries. Some Mg²⁺ ions have dissolved into the lattice to substitute Ti⁴⁺ ions on the B site of BaTiO₃ maintaining the perovskite structure of solid solution with additional phases such as TiO₂ and TiO when MgO content is greater than 5 mol%. The results confirm the ones carried out in [21]. Concerning the microstructure of this system, abnormal grain growth was found in pure BaTiO₃ with a 10μm average grain size. After addition of MgO particles into the system, the grain size decreased to less than 1μm for BTM5 and continuously decreased, with increasing MgO content (sample BTM10). MgO incorporation in the grain boundaries might be the grain growth inhibitor as reported in [8, 20-22].

High and stable electric permittivity, over a broad temperature range is significant for BaTiO₃-based ceramics due to their use in multi-layer ceramic capacitors [20, 23]. MgO is an important additive in BaTiO₃-based ceramics, because of its interesting electric properties. It has low electric permittivity (9 to 10.1), high dielectric strength (10 to 35kV/mm), apparent porosity null (%), tgδ around 9.10⁻⁴ and high use temperature (1800°C) [33-35]. The presence of MgO in BaTiO₃ matrix decreases the intergranular pores and increases the hardness of the MgO-BaTiO₃ composite [27]. The four samples (BTM15, BMT20, BMT30 and BMT50), have been processed to achieve ultra-broad-temperature stability.

B. Temperature Dependence of Dielectric Loss

Energy losses in ferroelectric materials are one of the most critical issues of high power devices. Ferroelectrics combined with MgO as a function of intrinsic and extrinsic defects should have other behavior regarding dielectric loss. The tgδ of a dielectric material is a useful indicator of dielectric loss. The samples with uniform microstructure, narrow grain size distribution, and less defects, exhibits low dielectric loss properties. Figure 5 shows the tgδ of the BTM0, BTM5, BTM10 samples over a temperature ranging from 25 to 300°C.

BTM0 exhibits broad peak between 270°C and 290°C. The dielectric loss increases with increasing MgO content. The maximum values of tgδ for the three samples are ~ 0.15, 0.25 and 1.15 and correspond to temperatures 285°C, 270°C and 270°C respectively. For BTM5 and BTM10 the maximum is shifted to 270°C. The moving of loss peaks towards low temperature with increasing Mg content has been reported in [19]. In higher temperature range (200-500°C), the high dielectric loss peak may be induced by the polarization of free space charge associated with a thermally active relaxation process. The results are in agreement with [19-21, 36]. Authors in [21] attribute the result to the increase in the oxygen vacancies. In our case the oxygen vacancy concentration increases with increasing MgO content, since Mg²⁺ is an acceptor for BaTiO₃ and a double ionized oxygen vacancy (Vₒ²⁻⁻) is formed in addition to the reduction of TiO₂ into TiO phase. However, MgO addition with multi-component BaTiO₃-based ceramics, for example BaTiO₃ co-doped with Y, Ga and Si [8], reduces dielectric loss, because of Y³⁺ doping. When the amount of MgO increases, (BTM15 and BTM20), the maxima of the loss curves shifted towards lower temperatures. These curves are characterized by oscillations around 200°C. At this temperature, the losses are greater than that of BTM5 and BTM10. The curve of the sample BTM20 presents a peak well resolved at 200°C. However, for the samples BTM30 and BTM50, the losses increase in comparison with that of BTM15 and BTM20, to reach respectively maxima at 9 and 12. These peaks are shifted towards higher temperatures (300°C) in comparison with that of BTM15 and BTM20. The increase of the losses can be so attributed to the increase of the oxygen.
vacancies with the increase of MgO such as previously explained for BTM5 and BTM10.

C. Temperature Dependence of Electrical Resistance

Figure 6 shows the resistance versus temperature, in the temperature range from 25°C to 400°C, of all samples. It is a typical resistance-temperature characteristic of a BaTiO₃ based PTCR material. Impurities and lattice imperfections play an important role in the exhibition of the PTC effect, in the doped samples, since the losses are in connection with these imperfections [21]. Their conductivities are influenced by intrinsic defects such as oxygen vacancies and cation vacancies, and the extrinsic defects produced by dopant addition. Here, divalent Mg ions (under oxide form) are added to substitute Ti ions in the BaTiO₃. The conductivity seems to be influenced by oxygen vacancies generated by Ti, and the lattice deformation of the composite (4.0119Å) is larger than that of pure BaTiO₃ (4.0060) (see Tables II and III), proving that Mg substitutes Ti. TiO phase has been detected in BTM10, contributing to cation vacancy generation. The evolution of resistance versus temperature in Figure 6 shows the influence of these imperfections on the resistance. We can see that as the MgO content increases, the resistance is increasing along. However, the switching temperatures of the samples BTM0 and BTM5 are around 270°C, whereas that of BTM10 is located at 225°C. The characteristic of BTM10 presents oscillations below the switching temperature (225°C). Authors in [17] attribute the temperature stability of the resistance, below the switching temperature (of PTCR ceramics), to the uniform grain size.

However, the curves of the samples BTM15, BTM20 are close in point of view form, and evolve in the same way with the sample BTM10. The maxima are less broad than that of BTM10 and their maxima are shifted towards 175°C. The minima are higher than the ones of the BM10. The sample BTM30 has a broad maximum which begins at 175°C and ends at 270°C. Its minimum is higher than the ones of BTM15 and BTM20. However, the curve of the sample BTM50 begins by a minimum, around 10000, greater than that of all other samples, and afterwards it increases to reach a maximum (around 300000), greater than that of all other samples. It is inferred that more MgO content reduces more TiO₂ into TiO or even into Ti, more cation vacancies are generated and the resistance is rising. This maximum appears at the Curie temperature (125°C) and ends with oscillations with a minimum well resolved at 300°C. These results confirm that, as MgO content increases, the dielectric loss of MgO-doped BaTiO₃ increases and Curie temperature shifts lower. Consequently, the resistance of the system increases. The result is in agreement with the findings in [21].

D. Electric Permittivity

Figure 7 shows the electric permittivity of MgO-doped BaTiO₃, for various MgO contents, in a temperature range from 20°C to 300°C. A sharp dielectric peak is recorded at Curie temperature (120°C) for BTM0. This Tc value has been found equal to the one reported in [20] for multicomponent BaTiO₃-based ceramics without MgO. Electric permittivity of BTM0 reaches almost 6000 while in [20], it is only 1700. However, MgO effect on BaTiO₃ begins to appear on BTM5 by an enlargement of εₘ peak. εₘ maximum (5000) is located at 50°C. This enlargement of εₘ peak, has been indicated in [20] for samples containing 1.0wt%, 1.5wt% and 2wt% MgO, where maxima (around 2000) was located at 250°C. However, εₘ of BTM10 and BMT15, corresponding to the maximum and Tc=80°C, has been evaluated to 4500 and 4250 respectively. The minima are located around 240°C. A broaden peak has been recorded for BTM5. Mg plays a role, in Curie peak depression [8]. The εₘ peak is shifted towards lower temperatures. Authors in [21] attribute this result to the diffuseness of the phase transition. The electric permittivity decreases with increasing MgO content. This is in agreement with [8, 16, 21-23]. Our samples contain MgO, TiO₂ and TiO phases in the grain boundaries and even perhaps Ti in BTM30 and BTM50. BTM30 and BTM50 can be even two phase materials, with MgO as continuous phase. The grain boundary is a non-ferroelectric phase, therefore its electric permittivity is lower. Otherwise, the permittivity at room temperature can be explained by the ionic polarization. This one can be calculated using the Clausius-Mossotti equation [8]. εₘ decreases with increasing Mg, because of the decrease in ionic polarizability (α) of the dipole as shown in [8]. The more the MgO content is, the smaller the grain size, and the lower the εₘ. This justifies that εₘ changes as a function of MgO content over the studied temperature range (from ambient temperature to 250°C). At 250°C and beyond, the curves of εₘ (BTM0 and BTM10) present a minimum and increase again. However, for BTM5, the minimum appears at 350°C from which εₘ begins to increase slowly but remains smaller than that of BTM0 and BTM10. Concerning the samples BTM20 and BTM 30, the
curve evolution of $\varepsilon_r$ kept the same form but their maxima, evaluated respectively to 4250 and less than 4000, are shifted towards 100°C. With 20 mol.% of MgO and more (30 mol.%) as dopant, $T_c$ shifts slightly again towards higher temperatures. After the minimum located at 300°C, as we can see in Figure 7, the $\varepsilon_r$ of BTM30 decreases in comparison with that of BTM20. This part of the curve is comparable with that of BTM10. The $\varepsilon_r$ of BTM50 is equal to 500. It is 10 times smaller than that of BTM5 and 12 times smaller than that of BTM0. Its curve is characterized by small maxima at 120°C and 200°C and ends by an increase towards 1000 at 400°C. The $\varepsilon_r$ of the sample BTM50 is close to the value found in [25] where BaTiO$_3$ and MgO were both in the ratios 50% in volume. The $\varepsilon_r$ of the two phase material depends not only on the electric permittivity of the two phases (MgO and BTiO$_3$), but it is highly affected by the structure (phase distribution and grain size) and the stress level between the phases as a result of the differences in their thermal expansion result [25]. The two phases, are promising for the development of high electric permittivity and high dielectric strength capacitors, therefore, the breakdown voltage is expected to be high, since the paraelectric (MgO) phase is continuous at this concentration [25]. Our results confirm the findings in [25] since TiO$_2$ and TiO phases have vanished in BTM50. Sample BTM50 is a two phase material which is promising to have excellent thermal shock resistance, mechanical strength, and chemical resistance properties.

**Fig. 7.** Temperature dependence of electric permittivity

### IV. CONCLUSION

The effects of MgO additions on the microstructure and the dielectric properties of BaTiO$_3$ have been studied. Oxides MgO and TiO$_2$ have been detected in the sample BTM5. MgO, TiO$_2$ and TiO were detected in the sample BTM10. MgO addition at 10 mol.%, and more, reduces the TiO$_2$ phase into TiO phase and can be even reduced into Ti phase. The grain size strongly depends on the MgO content. The average grain size of pure BaTiO$_3$ was near 10$\mu$m, whereas that of doped samples was about 1$\mu$m for BTM5 and some hundred nanometers for BTM10. The bimodal microstructure of fine and large matrix grains in BTM0 has been attributed to the temperature effect and to the presence of titanium oxide. $\varepsilon_r$ decreases with increasing MgO content, while grain size and $\varepsilon_r$ decrease. The electric permittivity of BTM50 was 12 times smaller than that of BTM0. The maximum peak was broader for increased MgO content. The $T_c$ of BTM10 and BTM15 has been evaluated to 80°C, and to 100°C for BTM20 and BTM30. Beyond 15mol.% MgO, $T_c$ is shifted again towards higher temperatures. The Curie temperature of BTM50 was equal to that of BTM0 (120°C). The conductivity is influenced by intrinsic defects, oxygen vacancies, and cation vacancies. The extrinsic defects were produced by dopant addition. Divalent ions (Mg) substitute Ti ions. Consequently, the conductivity was influenced by oxygen vacancies generated by Ti and the lattice deformation of the composite. The dielectric loss increases strongly with increasing MgO content. The loss peak, shifts towards low temperatures with increasing MgO content, whereas it may be induced by the polarization of free space charge associated with a thermally active relaxation process. The highest loss (tgδ=12) has been measured on the BTM50, whereas that of BTM30 was equal to 9. The lowest loss has been measured on BTM0 (tgδ=0.2) and BTM5 (tgδ=0.3). TiO$_2$ and TiO phases have probably vanished in BTM30 and BTM50 samples. These samples, particularly BTM50, can be considered as two-phase materials, which is promising regarding shock resistance, mechanical strength and chemical resistance properties.

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